



SCOPE OF ACCREDITATION TO ISO 17025:2005  
& ANSI/NCSL Z540-1-1994

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CALIBRATION

Valid To: April 30, 2018

Certificate Number: 2073.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations<sup>1</sup>:


I. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments
DC Resistance – Measure, Fixed Points	100 Ω 10 kΩ	0.32 μΩ/Ω 0.32 μΩ/Ω	esi 123 system w/IET (esi) SR104
DC Resistance – Measure	(0.1 to 1) Ω	0.52 μΩ/Ω	MIL 6010C system w/ SR-104
	(1 to 10) Ω	0.42 μΩ/Ω	
	(10 to 100) Ω	0.33 μΩ/Ω	
	100 Ω to 1 kΩ	0.24 μΩ/Ω	
	(1 to 10) kΩ	0.16 μΩ/Ω	
	(10 to 100) kΩ	0.46 μΩ/Ω	MIL 6000B system w/ SR104 and SRL standards
	100 kΩ to 1 MΩ	0.62 μΩ/Ω	
	(1 to 10) MΩ	1.0 μΩ/Ω	
	(10 to 100) MΩ	4.2 μΩ/Ω	
	100 MΩ to 1 GΩ	9.8 μΩ/Ω	
	0.1 mΩ	0.050 %	Current characterization method w/standards
	(0.2 to 1) mΩ	29 μΩ/Ω + 41 nΩ	
	(1 to 2) mΩ	46 μΩ/Ω + 23 nΩ	
(2 to 20) mΩ	57 μΩ/Ω		
(20 to 100) mΩ	17 μΩ/Ω + 3 nΩ		
(100 to 200) mΩ	25 μΩ/Ω		
(0.2 to 1) Ω	6 μΩ/Ω + 3.4 μΩ		

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments	
DC Resistance – Measure (cont)	(1 to 2) Ω	7 μΩ/Ω + 2.4 μΩ	Ratio transfer method	
	(2 to 20) Ω	4 μΩ/Ω + 10 μΩ		
	(20 to 200) Ω	2.7 μΩ/Ω + 20 μΩ		
	200 Ω to 2 kΩ	3.8 μΩ/Ω + 60 μΩ		
	(2 to 20) kΩ	0.9 μΩ/Ω + 2 mΩ		
	(20 to 200) kΩ	2.7 μΩ/Ω + 10 mΩ		
	200 kΩ to 2 MΩ	3 μΩ/Ω + 0.6 Ω		
	(2 to 20) MΩ	6.3 μΩ/Ω + 2 Ω		
	(20 to 200) MΩ	8.5 μΩ/Ω		Voltage characterization method w/standards
	200 MΩ to 2 GΩ	0.0026 %		
	(2 to 20) GΩ	0.03 %		
	200 GΩ to 1 TΩ	0.35 %		Keithley 6517A w/ faraday cage
(1 to 2) TΩ		0.5 %		
(2 to 20) TΩ		1.5 %		
(20 to 200) TΩ		2.5 %		
DC Resistance – Generate, Fixed Points	0.1 mΩ	4 μΩ/Ω	Otto Wolff 15283/61 L&N 4223-B Guildline 9334A SRL-0.1 SRL-1 SRL-10 IET (esi) SR-102 Guildline 9334A IET (esi) SR-104 SRL-100k SRL-1M SRL-10M Guildline 9334A SRL-1G SRC-10G SRL-100G OhmLabs 112 OhmLabs 113	
	1 mΩ	4 μΩ/Ω		
	10 mΩ	4 μΩ/Ω		
	100 mΩ	4 μΩ/Ω		
	1 Ω	4 μΩ/Ω		
	10 Ω	4 μΩ/Ω		
	100 Ω	1 μΩ/Ω		
	1 kΩ	1.7 μΩ/Ω		
	10 kΩ	0.5 μΩ/Ω		
	100 kΩ	3.7 μΩ/Ω		
	1 MΩ	3.7 μΩ/Ω		
	10 MΩ	6.2 μΩ/Ω		
	100 MΩ	10 μΩ/Ω		
	1 GΩ	100 μΩ/Ω		
	10 GΩ	100 μΩ/Ω		
	100 GΩ	0.020 %		
	1 TΩ	0.025 %		
	10 TΩ	0.10 %		



Parameter/Range	Frequency	CMC <sup>2,4</sup> (±)	Comments
Capacitance – Measure, Fixed Points  1 pF 10 pF 100 pF 1000 pF	1000 Hz	0.01 % + 30 aF 5.7 μF/F 5.9 μF/F 4.8 μF/F	IET (GenRad) 1404 and 1620
Capacitance – Measure  10 abF to 11 μF 10 abF to 100 mF 10 abF to 10 F	50 Hz to 1 kHz 12 Hz to 200 kHz 10 Hz to 2 MHz	0.01 % + 30 aF 0.01 % 0.05 % + 50 aF	IET (GenRad) 1620 IET (GenRad) 1689/1693 IET (Quadtech) 7600+
Capacitance – Generate  10 aF to 11 μF 10 aF to 100 mF 10 aF to 10 F  Fixed Points: 1 pF 10 pF 100 pF 1000 pF 10 nF 100 nF 1 μF 10 μF 100 μF 1 mF 10 mF 100 mF 1 F  Fixed Points Algorithmic Derivation @ Freq: 50 pF 100 pF 200 pF 500 pF 1 nF 2 nF 10 nF 20 nF 50 nF 100 nF	50 Hz to 1 kHz 12 Hz to 200 kHz 10 Hz to 2 MHz  1 kHz  100 Hz  1 kHz to 1 MHz	0.01 % + 30 aF 0.01 % 0.05 % + 50 aF  0.01 % 4 μF/F 5 μF/F 6 μF/F 0.01 % 0.01 % 0.01 % 0.02 % 0.05 % 0.4 % 0.3 % 0.4 % 0.6 %  0.017 % 0.021 % 0.014 % 0.012 % 0.013 % 0.016 % 0.057 % 0.12 % 0.028 % 0.56 %	Various standard capacitors characterized at time of use  Fused silica standard IET (GenRad) 1404-C IET (GenRad) 1404-B IET (GenRad) 1404-A IET SC-10 nF IET SC-100 nF IET SC-1 μF IET SC-10 μF IET S-100 μF IET (GenRad) 1417 IET (GenRad) 1417 IET (GenRad) 1417 IET (GenRad) 1417  GR/IET 1406E GR/IET 1406D GR/IET 1406C GR/IET 1406B GR/IET 1406A GR/IET 1407B GR/IET 1407D GR/IET 1407E GR/IET 1407F GR/IET 1407G



Parameter/Range	Frequency	CMC <sup>2,4</sup> (±)	Comments
Inductance – Measure			
10 nH to 100 kH	12 Hz to 100 kHz	0.01 %	IET (GenRad) 1689/1693
1 pH to 100 H	10 Hz to 2 MHz	0.05 % + 5 pH	IET (Quadtech) 7600+
Inductance – Measure, Fixed Points			
10 μH	100 Hz 400 Hz 1 kHz 10 kHz 100 kHz	1.5 % 0.29 % 0.12 % 0.07 % 0.10 %	IET (GenRad) 1482 standard inductors w/ precision LCR meter
50 μH	100 Hz 400 Hz 1 kHz 10 kHz	0.31 % 0.08 % 0.04 % 0.06 %	
100 μH	100 Hz 200 Hz 400 Hz 1 kHz 10 kHz	0.017 % 0.017 % 0.017 % 0.011 % 0.017 %	
200 μH	100 Hz 400 Hz 1 kHz 10 kHz	0.1 % 0.04 % 0.03 % 0.06 %	
500 μH	100 Hz 400 Hz 1 kHz 10 kHz	0.06 % 0.03 % 0.02 % 0.06 %	
1 mH	100 Hz 200 Hz 400 Hz 1 kHz 10 kHz	0.012 % 0.012 % 0.012 % 0.011 % 0.017 %	
2 mH	100 Hz 400 Hz 1 kHz 10 kHz	0.04 % 0.03 % 0.02 % 0.06 %	



Parameter/Range	Frequency	CMC <sup>2,4</sup> (±)	Comments	
Inductance – Measure, Fixed Points (cont)	5 mH	100 Hz	0.03 %	IET (GenRad) 1482 standard inductors with precision LCR meter
		400 Hz	0.02 %	
		1 kHz	0.02 %	
		10 kHz	0.06 %	
	10 mH	100 Hz	0.013 %	
		200 Hz	0.013 %	
		400 Hz	0.013 %	
		1 kHz	0.011 %	
		10 kHz	0.015 %	
	20 mH	100 Hz	0.03 %	
		400 Hz	0.02 %	
		1 kHz	0.02 %	
		10 kHz	0.07 %	
	50 mH	100 Hz	0.015 %	
		200 Hz	0.015 %	
		400 Hz	0.015 %	
		1 kHz	0.014 %	
		10 kHz	0.023 %	
	100 mH	100 Hz	0.012 %	
		200 Hz	0.012 %	
		400 Hz	0.012 %	
		1 kHz	0.011 %	
		10 kHz	0.021 %	
	200 mH	100 Hz	0.015 %	
		200 Hz	0.015 %	
		400 Hz	0.015 %	
		1 kHz	0.014 %	
		10 kHz	0.051 %	
500 mH	100 Hz	0.015 %		
	200 Hz	0.015 %		
	400 Hz	0.015 %		
	1 kHz	0.014 %		
	10 kHz	0.051 %		
1 H	100 Hz	0.011 %		
	200 Hz	0.011 %		
	400 Hz	0.011 %		
	1 kHz	0.011 %		



Parameter/Range	Frequency	CMC <sup>2,4</sup> (±)	Comments	
Inductance – Measure, Fixed Points (cont)	2 H	100 Hz	0.03 %	IET (GenRad) 1482 standard inductors w/ precision LCR meter
		400 Hz	0.03 %	
		1 kHz	0.03 %	
	5 H	100 Hz	0.03 %	
		200 Hz	0.03 %	
		400 Hz	0.03 %	
		1 kHz	0.04 %	
	10 H	100 Hz	0.012 %	
		200 Hz	0.012 %	
		400 Hz	0.012 %	
		1 kHz	0.011 %	
	Inductance – Generate, Fixed Points	10 μH	100 Hz	
400 Hz			0.29 %	
1 kHz			0.12 %	
10 kHz			0.07 %	
100 kHz			0.10 %	
50 μH		100 Hz	0.31 %	
		400 Hz	0.08 %	
		1 kHz	0.04 %	
		10 kHz	0.06 %	
100 μH		100 Hz	0.017 %	
		200 Hz	0.017 %	
		400 Hz	0.017 %	
		1 kHz	0.011 %	
		10 kHz	0.017 %	
200 μH		100 Hz	0.1 %	
		400 Hz	0.04 %	
		1 kHz	0.03 %	
		10 kHz	0.06 %	



Parameter/Range	Frequency	CMC <sup>2,4</sup> (±)	Comments	
Inductance – Generate, Fixed Points (cont)	500 µH	100 Hz	0.06 %	IET (GenRad) 1482 standard inductors
		400 Hz	0.03 %	
		1 kHz	0.02 %	
		10 kHz	0.06 %	
	1 mH	100 Hz	0.012 %	
		200 Hz	0.012 %	
		400 Hz	0.012 %	
		1 kHz	0.011 %	
		10 kHz	0.017 %	
	2 mH	100 Hz	0.04 %	
		400 Hz	0.03 %	
		1 kHz	0.02 %	
		10 kHz	0.06 %	
	5 mH	100 Hz	0.03 %	
		400 Hz	0.02 %	
		1 kHz	0.02 %	
		10 kHz	0.06 %	
	10 mH	100 Hz	0.013 %	
		200 Hz	0.013 %	
		400 Hz	0.013 %	
		1 kHz	0.011 %	
		10 kHz	0.015 %	
	20 mH	100 Hz	0.03 %	
		400 Hz	0.02 %	
		1 kHz	0.02 %	
		10 kHz	0.07 %	
	50 mH	100 Hz	0.015 %	
		200 Hz	0.015 %	
		400 Hz	0.015 %	
		1 kHz	0.014 %	
		10 kHz	0.023 %	
	100 mH	100 Hz	0.012 %	
		200 Hz	0.012 %	
		400 Hz	0.012 %	
		1 kHz	0.011 %	
		10 kHz	0.021 %	



Parameter/Range	Frequency	CMC <sup>2,4</sup> (±)	Comments	
Inductance – Generate, Fixed Points (cont)	200 mH	100 Hz	0.015 %	IET (GenRad) 1482 standard inductors
		200 Hz	0.015 %	
		400 Hz	0.015 %	
		1 kHz	0.014 %	
		10 kHz	0.051 %	
	500 mH	100 Hz	0.015 %	
		200 Hz	0.015 %	
		400 Hz	0.015 %	
		1 kHz	0.014 %	
		10 kHz	0.051 %	
	1 H	100 Hz	0.011 %	
		200 Hz	0.011 %	
		400 Hz	0.011 %	
		1 kHz	0.011 %	
	2 H	100 Hz	0.03 %	
		400 Hz	0.03 %	
		1 kHz	0.03 %	
	5 H	100 Hz	0.03 %	
		400 Hz	0.03 %	
		1 kHz	0.04 %	
	10 H	100 Hz	0.012 %	
		200 Hz	0.012 %	
		400 Hz	0.012 %	
		1 kHz	0.011 %	

Parameter/Equipment	Range	CMC <sup>2,3</sup> (±)	Comments
DC Voltage Generate – Cardinal Points	1 V 1.018 V 10 V	3.6 µV/V 2.8 µV/V 1.6 µV/V	Keop Trancell DC voltage standard model VTS6001-1
DC Voltage – Measure	(0 to 200) mV 200 mV to 2 V (2 to 20) V (20 to 200) V (200 to 1000) V	4.5 µV/V + 0.1 µV 3 µV/V + 0.4 µV 3 µV/V + 4 µV 4.5 µV/V + 40 µV 4.5 µV/V + 0.5 mV	Fluke 8508A





Parameter/Equipment	Range	CMC <sup>2,3</sup> (±)	Comments
DC Current – Measure	(0 to 200) µA 200 µA to 2 mA (2 to 20) mA (20 to 200) mA 200 mA to 2 A (2 to 20) A	12 µA/A + 0.2 nA 12 µA/A + 2 nA 13 µA/A + 20 nA 36 µA/A + 0.4 µA 0.017 % + 8 µA 0.038 % + 20 µA	Fluke 8508A

Parameter/Range	Frequency	CMC <sup>2,3</sup> (±)	Comments
AC Voltage – Measure			
(0 to 200) mV	(10 to 40) Hz (40 to 100) Hz 100 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.013 % + 4 µV 0.011 % + 4 µV 0.011 % + 2 µV 0.011 % + 4 µV 0.030 % + 8 µV 0.071 % + 20 µV	Fluke 8508A
(0.2 to 2) V	(10 to 40) Hz (40 to 100) Hz 100 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.011 % + 20 µV 85 µV/V + 20 µV 65 µV/V + 20 µV 85 µV/V + 20 µV 0.021 % + 40 µV 0.051 % + 200 µV 0.3 % + 2 mV 1 % + 2 mV	
(2 to 20) V	(10 to 40) Hz (40 to 100) Hz 100 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.011 % + 200 µV 85 µV/V + 200 µV 65 µV/V + 200 µV 85 µV/V + 200 µV 0.021 % + 400 µV 0.051 % + 2 mV 0.3 % + 20 mV 1 % + 20 mV	



Parameter/Range	Frequency	CMC <sup>2,3,4</sup> (±)	Comments
AC Voltage – Measure (cont)			
(20 to 200) V	(10 to 40) Hz (40 to 100) Hz 100 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.011 % + 2 mV 85 μV/V + 2 mV 65 μV/V + 2 mV 85 μV/V + 2 mV 0.021 % + 4 mV 0.051 % + 20 mV 0.3 % + 200 mV 1 % + 200 mV	Fluke 8508A
(200 to 1050) V	(10 to 40) Hz (40 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.011 % + 0.02 V 95 μV/V + 0.02 V 0.021 % + 0.04 V 0.051 % + 0.2 V	
AC Current – Measure			
(0 to 200) μA	10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.028 % + 0.02 μA 0.065 % + 0.02 μA 0.4 % + 0.02 μA	Fluke 8508A
200 μA to 2 mA	10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.028 % + 0.2 μA 0.065 % + 0.2 μA 0.4 % + 0.2 μA	
(2 to 20) mA	10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.028 % + 2 μA 0.065 % + 2 μA 0.4 % + 2 μA	
(20 to 200) mA	10 Hz to 10 kHz (10 to 30) kHz	0.025 % + 20 μA 0.060 % + 20 μA	
200 mA to 2 A	10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.060 % + 200 μA 0.070 % + 200 μA 0.3 % + 200 μA	
(2 to 20) A	10 Hz to 2 kHz (2 to 10) kHz	0.08 % + 2 mA 0.25 % + 2 mA	
AC Resistance – Measure			
0.01 mΩ to 100 MΩ 0.1 mΩ to 100 MΩ	12 Hz to 200 kHz 10 Hz to 2 MHz	0.01 % 0.05 %	IET (GenRad) 1689/1693 Quadtech 7600



Parameter/Range	Frequency	CMC <sup>2</sup> (±)	Comments
AC Resistance – Generate			
Fixed Points: 24.9 Ω	1 kHz	20 μΩ/Ω	IET (GenRad) 1689-9604 Digibridge calibration kit
374 Ω	1 kHz	20 μΩ/Ω	
5.97 kΩ	1 kHz	20 μΩ/Ω	
95.317 kΩ	1 kHz	20 μΩ/Ω	

## II. Time & Frequency

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Frequency – Measure	0.01 Hz to 125 MHz	20 μHz/Hz	Precision counter

<sup>1</sup> This laboratory offers commercial calibration service.

<sup>2</sup> Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of  $k = 2$ . The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

<sup>3</sup> The measurands stated are measured with the Fluke 8508A. This capability is suitable for the calibration of the parameters indicated. CMCs are expressed as either a specific value that covers the full range or as a combination of the fraction/percent of the reading/output plus a range specification.

<sup>4</sup> In the statement of CMC, percentages are to be read as percent of reading unless otherwise noted.



## *Accredited Laboratory*

A2LA has accredited

**IET LABS, INC.**

*West Roxbury, MA*

for technical competence in the field of

### Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSLI Z540-1-1994 and any additional program requirements in the field of calibration. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated 8 January 2009).



Presented this 24<sup>th</sup> day of March 2016.

A handwritten signature in black ink, written over a horizontal line.

President and CEO  
For the Accreditation Council  
Certificate Number 2073.01  
Valid to April 30, 2018

*For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.*